

**Search Notes**

Application/Control No.

10/780,218

Examiner

Stephen E. Jones

Applicant(s)/Patent under  
Reexamination

LIANG ET AL.

Art Unit

2817

**SEARCHED**

Class	Subclass	Date	Examiner
333	204, 205, 219, 235, 174, 134	1/26/05	SJ

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
consulted: J. Bettendorf regarding Zappala ref.	1/26/2005	SJ